Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent ur Reexamination	nder
10/046,633	ALEXEI GOROKHO\	/
Examiner	Art Unit	
Erin M. File	2634	

	SEARCHED		
Class	Subclass	Date	Examiner
370	206	4/5/2005	EMF
370	207	4/5/2005	EMF
375	259	4/5/2005	EMF
375	260	4/5/2005	EMF
375	261	4/5/2005	EMF
375	298	4/5/2005	EMF
375	316	4/5/2005	EMF
455	60	4/5/2005	EMF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		-	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	4/5/2005	EMF
PALM INVENTORSHIP	4/5/2005	EMF
IEEE Keyword Searches	4/5/2005	EMF
Google Search	4/5/2005	EMF